

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567481	SHEN ET AL.
	Examiner	Art Unit
	M. Lee	2622

SEARCHED

Class	Subclass	Date	Examiner
348	725, 552-558, 705, 706	8/29/08	ml

SEARCH NOTES

Search Notes	Date	Examiner
east	8/29/08	ml

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner. Art Unit 2622
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